

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/531,456	NICU ET AL.
	Examiner	Art Unit
	Helen C. Kwok	2856

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
73	504.12	9/5/2006	HK
73	504.14	9/5/2006	HK